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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Filing Date	Herewith
		First Named Inventor	Otomo et al.
		Art Unit	Not Yet Assigned 2816
		Examiner Name	Not Yet Assigned Khareem Almo
Sheet	1 of 1	Attorney Docket	85366

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ²	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
KA		US-6,225,831 B1	05/01/2001	Dalmia et al.	
KA		US-6,421,404 B1	07/16/2002	Nakamura	
KA		US-2003/0142774 A1	07/31/2003	Takasoh et al.	

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Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶	
		Country Code ³ -Number ⁴ -Kind Code ⁵					
KA		JP2000077990	03/14/2000	Victor Co. of Japan Ltd.		X	
KA		JP2001144592	05/25/2001	Fujitsu Ltd.		X	
KA		JP2002171160	06/14/2002	Nec Eng Ltd.		X	

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
KA		NAKAMURA, KAZUYUKI; FUKAISHI, MUNEO; ABIKO, HITOSHI; MATSUMOTO, AKIRA and YOTSUYANAGI, MICHIO, A 6 Gbps CMOS Phase Detecting DEMUX Module Using Half-Frequency Clock, IEEE, 1998	
KA		SAVOJ, JAFAR and RAZAVI, BEHZAD, A 10-Gb/s CMOS Clock and Data Recovery Circuit with a Half-Rate Linear Phase Detector, IEEE Journal of Solid-State Circuits, Vol. 36, No. 5, May 2001, pages 761-768.	
KA		OHTOMO, YUSUKE; KAWAMURA, TOMOAKI; NISHIMURA, KAZUYOSHI, NOGAWA, MASAFUMI; KOIZUMI, HIROSHI and TOGASHI, MINOURU, A 12.5 Gb/s CMOS BER Test Using A Jitter-Tolerant Parallel CDR, IEEE International Solid-State Circuits Conference, ISSCC Digest of Technical Papers, Feb. 2004, pages 174-175.	

Examiner Signature	/Khareem Almo/	Date Considered	07/20/2006
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